# SiSS5108DN

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**Vishay Siliconix** 

## N-Channel 100 V (D-S) MOSFET

# PowerPAK® 1212-8S D 8 G Top View Bottom View

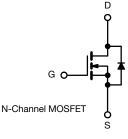
**PRODUCT SUMMARY** 100 V<sub>DS</sub> (V) 0.0105  $R_{DS(on)}$  max. ( $\Omega$ ) at  $V_{GS} = 10$  V  $R_{DS(on)}$  max. ( $\Omega$ ) at  $V_{GS}$  = 7.5 V 0.0124 Q<sub>q</sub> typ. (nC) 11.2 55.9 I<sub>D</sub> (A) <sup>a</sup> Configuration Single

#### **FEATURES**

- TrenchFET<sup>®</sup> Gen V power MOSFET
- Very low R<sub>DS</sub> x Q<sub>g</sub> figure-of-merit (FOM)
- Tuned for the lowest R<sub>DS</sub> x Q<sub>oss</sub> FOM
- 100 % R<sub>q</sub> and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

#### **APPLICATIONS**

- Synchronous rectification
- · Primary side switch
- DC/DC converters
- Power supplies
- Motor drive control



ORDERING INFORMATION	
Package	PowerPAK 1212-8S
Lead (Pb)-free and halogen-free	SiSS5108DN-T1-GE3

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		V <sub>DS</sub>	100	V
Gate-source voltage		V <sub>GS</sub>	± 20	V
Continuous drain current (T <sub>J</sub> = 150 °C)	T <sub>C</sub> = 25 °C		55.9	
	T <sub>C</sub> = 70 °C	Ι. Γ	44.7	
	T <sub>A</sub> = 25 °C		15.4 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C	1 –	12.3 <sup>b, c</sup>	
Pulsed drain current (t = 100 µs)		I <sub>DM</sub>	120	— A
Continuous source-drain diode current	T <sub>C</sub> = 25 °C		59.8	
	T <sub>A</sub> = 25 °C	I <sub>S</sub>	4.5 <sup>b, c</sup>	
Single pulse avalanche current	L = 0.1 mH	I <sub>AS</sub>	20	
Single pulse avalanche energy	L = 0.1 MH	E <sub>AS</sub>	20	mJ
Maximum power dissipation	T <sub>C</sub> = 25 °C		65.7	
	T <sub>C</sub> = 70 °C		42.1	14/
	T <sub>A</sub> = 25 °C	P <sub>D</sub> –	5 <sup>b, c</sup>	W
	T <sub>A</sub> = 70 °C	1 –	3.2 <sup>b, c</sup>	
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	*0
Soldering recommendations (peak temperature) d, e			260	°C

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction to ambient <sup>b</sup>	t ≤ 10 s	R <sub>thJA</sub>	20	25	°C/W	
Maximum junction to case (drain)	Steady state	R <sub>thJC</sub>	1.5	1.9	- 0/10	

Notes

a. T<sub>C</sub> = 25 °C b. Surface mounted on 1" x 1" FR4 board

t = 10 s

See solder profile (<u>www.vishay.com/doc?73257</u>). The PowerPAK 1212-8S is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection Rework conditions: manual soldering with a soldering iron is not recommended for leadless components d.

e.

Maximum under steady state conditions is 63 °C/W f.

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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static			•		•		
Drain-source breakdown voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_{D} = 1 mA$	100	-	-	V	
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 10 mA	-	54	-		
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	-	-7.8	-	mV/°C	
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2	-	4	V	
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$	-	-	± 100	nA	
Zero gate voltage drain current	I <sub>DSS</sub> –	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1		
		$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 70 ^{\circ}\text{C}$	-	-	15	μA	
Drain-source on-state resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A	-	0.0087	0.0105	Ω	
		$V_{GS} = 7.5 \text{ V}, \text{ I}_{D} = 10 \text{ A}$	-	0.0102	0.0124		
Forward transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 10 A	-	34	-	S	
Dynamic <sup>b</sup>				······			
Input capacitance	C <sub>iss</sub>	$V_{DS}$ = 50 V, $V_{GS}$ = 0 V, f = 1 MHz	-	1150	-	pF	
Output capacitance	C <sub>oss</sub>		-	480	-		
Reverse transfer capacitance	C <sub>rss</sub>		-	8.4	-		
	$Q_{g}$ $V_{DS} = 50 \text{ V},  V_{GS} = 10 \text{ V},  I_{D} = 10 \text{ A}$	$V_{DS} = 50 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 10 \text{ A}$	-	14.8	23	1	
Total gate charge		-	11.2	17	1		
Gate-source charge	Q <sub>gs</sub>	$V_{DS}$ = 50 V, $V_{GS}$ = 7.5 V, $I_{D}$ = 10 A	-	6.3	-	nC	
Gate-drain charge	Q <sub>qd</sub>		-	1.3	-		
Output charge	Q <sub>oss</sub>	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$	-	44	-		
Gate resistance	Rg	f = 1 MHz	0.4	1.0	1.7	Ω	
Turn-on delay time	t <sub>d(on)</sub>		-	11	22	-	
Rise time	t <sub>r</sub>	$\label{eq:VDD} \begin{array}{l} V_{DD} = 50 \text{ V}, \ R_L = 5.0 \ \Omega \\ I_D \cong 10 \ \text{A}, \ V_{GEN} = 10 \ \text{V}, \ R_g = 1 \ \Omega \end{array}$	-	6	12		
Turn-off delay time	t <sub>d(off)</sub>		-	16	32		
Fall time	t <sub>f</sub>		-	7	14		
Turn-on delay time	t <sub>d(on)</sub>		-	14	28	ns	
Rise time	t <sub>r</sub>	$\label{eq:VDD} \begin{array}{l} V_{DD} = 50 \text{ V},  \text{R}_{\text{L}} = 5.0 \ \Omega \\ \text{I}_{\text{D}} \cong 10 \text{ A},  \text{V}_{\text{GEN}} = 7.5 \text{ V},  \text{R}_{\text{g}} = 1 \ \Omega \end{array}$	-	6	12	-	
Turn-off delay time	t <sub>d(off)</sub>		-	16	32		
Fall time	t <sub>f</sub>		-	7	14		
Drain-Source Body Diode Characteristic	s				•	1	
Continuous source-drain diode current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	59.8		
Pulse diode forward current ( $t_p = 100 \ \mu s$ )	I <sub>SM</sub>	-	-	-	120	A	
Body diode voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A	-	0.77	1.1	V	
Body diode reverse recovery time	t <sub>rr</sub>	-	-	40	80	ns	
Body diode reverse recovery charge	Q <sub>rr</sub>	I <sub>F</sub> = 10 A, di/dt = 100 A/μs,	-	43	86	nC	
Reverse recovery fall time	t <sub>a</sub>	$T_{\rm J} = 25 \ ^{\circ}{\rm C}$	-	20	-	ns	
Reverse recovery rise time	t <sub>b</sub>		-	20	-		

Notes

a. Pulse test; pulse width  $\leq 300~\mu\text{s},$  duty cycle  $\leq 2~\%$ 

b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

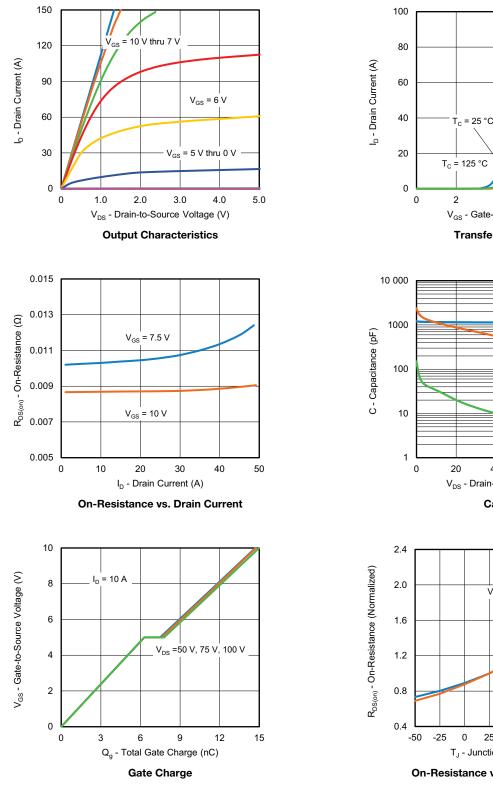
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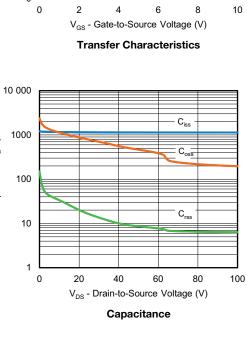


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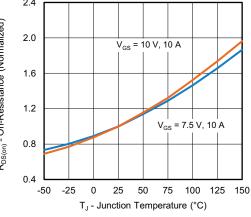
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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





T<sub>C</sub> = -55 °C



**On-Resistance vs. Junction Temperature** 

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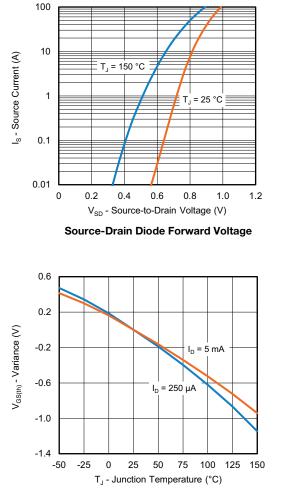
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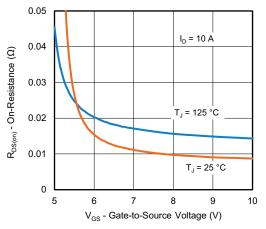


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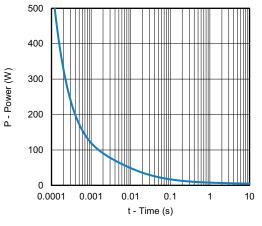
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



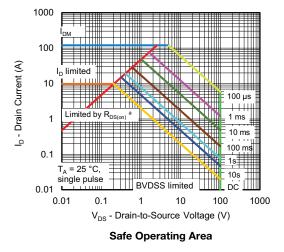
**Threshold Voltage** 



**On-Resistance vs. Gate-to-Source Voltage** 



Single Pulse Power, Junction-to-Ambient



#### Note

a. V<sub>GS</sub> > minimum V<sub>GS</sub> at which R<sub>DS(on)</sub> is specified

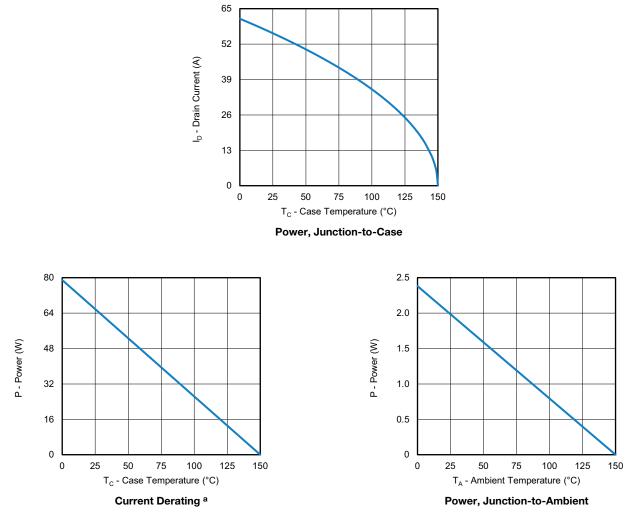
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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



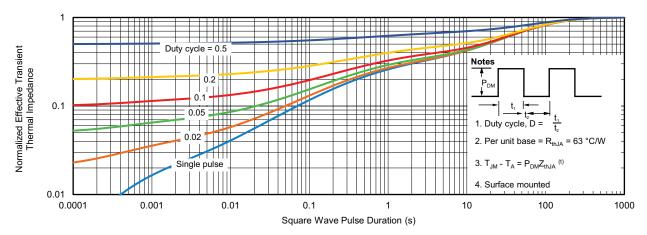
#### Note

a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

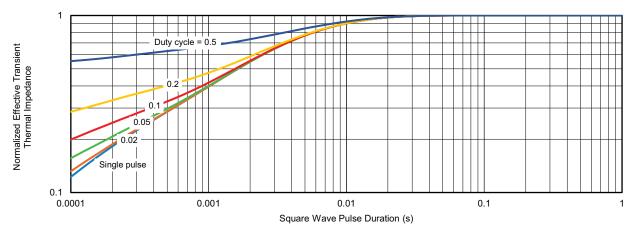


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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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